

### FEATURES

- High Voltage Operation :  $V_{DS}=50V$
- High Power : 53.5dBm (typ.) @  $P_{sat}$
- High Efficiency: 70%(typ.) @  $P_{sat}$
- Linear Gain : 17.5dB(typ.) @  $f=0.9GHz$
- Proven Reliability



### DESCRIPTION

SEI's GaN-HEMT offers high efficiency, ease of matching, greater consistency and broad bandwidth for high power L-band amplifiers with 50V operation, and gives you higher gain.

This new product is ideally suited for use in 0.9GHz LTE design requirements as it offers high gain, long term reliability and ease of use.

### ABSOLUTE MAXIMUM RATINGS (Case Temperature $T_c=25deg.C$ )

| Item                    | Symbol    | Condition    | Rating      | Unit  |
|-------------------------|-----------|--------------|-------------|-------|
| Operating-Voltage       | $V_{DS}$  |              | 55          | V     |
| Drain-Source Voltage    | $V_{DS}$  | $V_{GS}=-8V$ | 160         | V     |
| Gate-Source Voltage     | $V_{GS}$  |              | -15         | V     |
| Total Power Dissipation | $P_t$     |              | 173         | W     |
| Storage Temperature     | $T_{stg}$ |              | -65 to +175 | deg.C |
| Channel Temperature     | $T_{ch}$  |              | 250         | deg.C |

### RECOMMENDED OPERATING CONDITION

| Item                 | Symbol     | Condition   | Limit       | Unit  |
|----------------------|------------|-------------|-------------|-------|
| DC Input Voltage     | $V_{DS}$   |             | $\leq 55$   | V     |
| Forward Gate Current | $I_{GF}$   | $R_G=10ohm$ | $\leq 204$  | mA    |
| Reverse Gate Current | $I_{GR}$   | $R_G=10ohm$ | $\geq -7.8$ | mA    |
| Channel Temperature  | $T_{ch}$   |             | $\leq 180$  | deg.C |
| Average Output Power | $P_{ave.}$ |             | $\leq 50.5$ | dBm   |

### ELECTRICAL CHARACTERISTICS (Case Temperature $T_c=25deg.C$ )

| Item               | Symbol       | Condition                           | Limit |      |      | Unit    |
|--------------------|--------------|-------------------------------------|-------|------|------|---------|
|                    |              |                                     | Min.  | Typ. | Max. |         |
| Pinch-Off Voltage  | $V_p$        | $V_{DS}=50V$ $I_{DS}=54.4mA$        | -1.0  | -1.5 | -2.0 | V       |
| Saturated Power    | $P_{sat} *1$ | $V_{DS}=50V$                        | 52.5  | 53.5 | -    | dBm     |
| Drain Efficiency   | $\eta_d *2$  | $I_{DS}(DC)=750mA$                  | 30    | 35   | -    | %       |
| Power Gain         | $G_p *2$     | $f=0.9GHz$                          | 16.5  | 17.5 | -    | dB      |
| Thermal Resistance | $R_{th}$     | Channel to Case<br>at 105W $P_{DC}$ | -     | 1.1  | 1.3  | deg.C/W |

\*1 : 10%-duty RF pulse (DC supply constant)

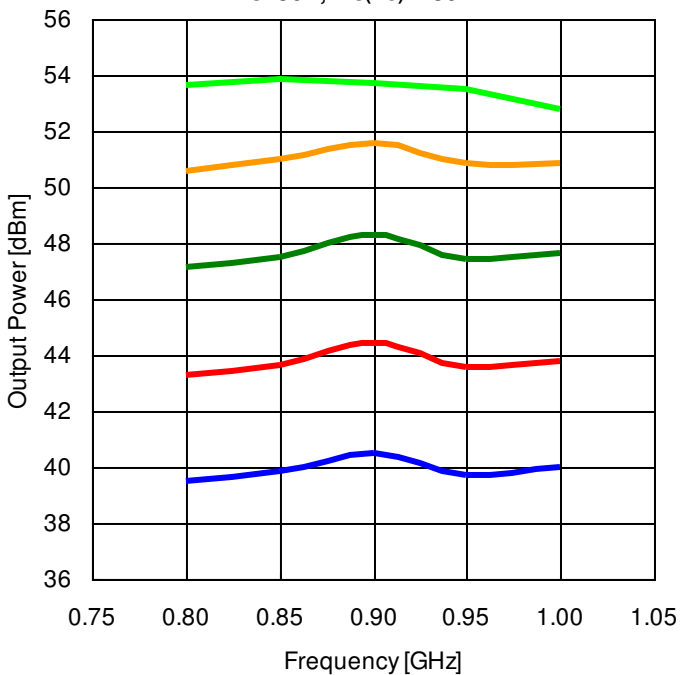
\*2 :  $P_{out} = 45.5dBm$ , CW modulation Signal (W-CDMA)

|                        |            |
|------------------------|------------|
| <b>RoHS COMPLIANCE</b> | <b>Yes</b> |
|------------------------|------------|

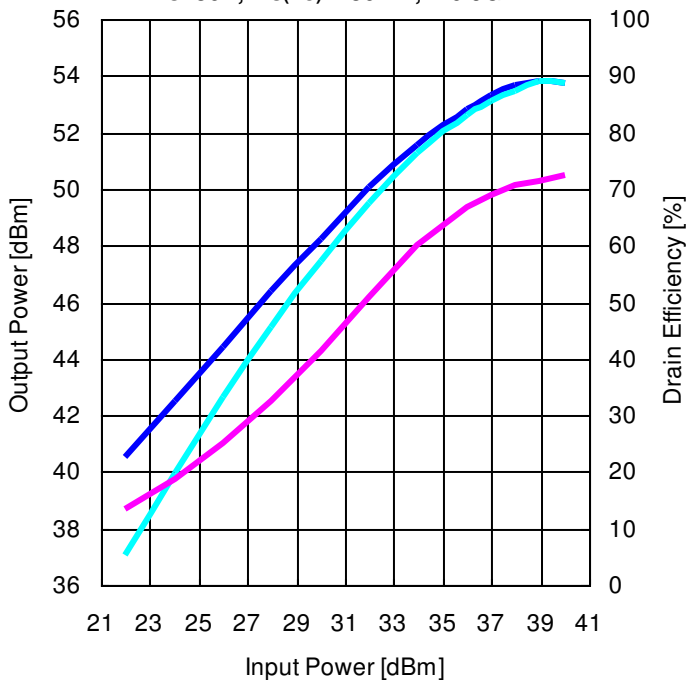
RF characteristics @f=0.9GHz fine tuned

High Voltage - High Power GaN-HEMT

Output Power vs. Frequency  
V<sub>ds</sub>=50V, I<sub>ds(DC)</sub>=750mA



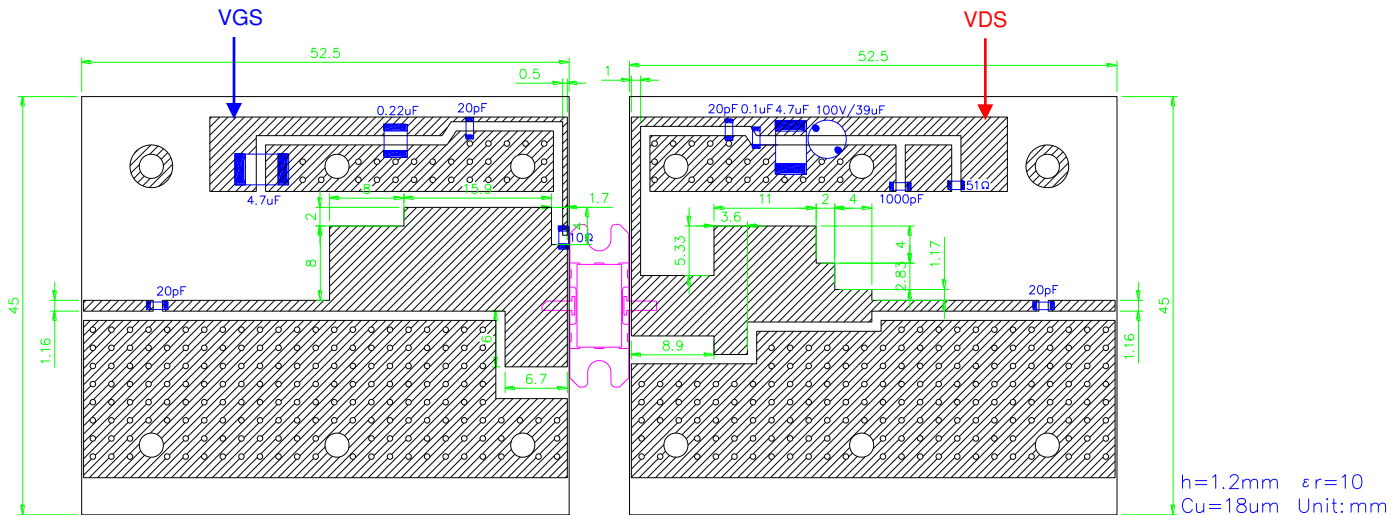
Output Power and Drain Efficiency vs. Input Power  
V<sub>ds</sub>=50V, I<sub>ds(DC)</sub>=750mA, f=0.9GHz



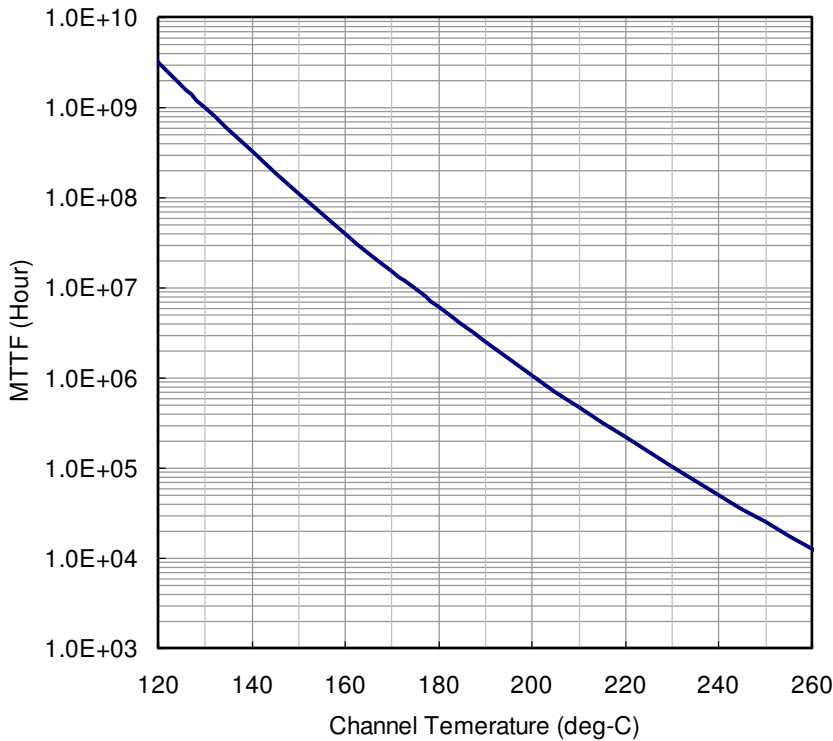
— Pin=22dBm    — Pin=26dBm    — Pin=30dBm  
— Pin=34dBm    — Pin=40dBm

— Pout (class AB)    — Pout (class B)    — Nd (class B)  
 Pulse Signal (10%-duty, DC : constant)

Test Fixture



### MTTF Calculation - Estimated MTTF -



Ea=1.6eV  
Confidence Level=90%

| Channel Temp (deg-C) | MTTF (Hours)           |
|----------------------|------------------------|
| 160                  | 4.05 x 10 <sup>7</sup> |
| 180                  | 6.07 x 10 <sup>6</sup> |
| 200                  | 1.07 x 10 <sup>6</sup> |

$$AF = \exp\left[-\frac{Ea}{k}\left(\frac{1}{T_{stress}} - \frac{1}{T_{use}}\right)\right]$$

$$MTTF_{use} = MTTF_{stress} * AF$$

Where;

AF: acceleration factor

Ea: activation energy (1.6 eV)

k: Boltzman's constant ( $8.62 \times 10^{-5}$  eV/K)

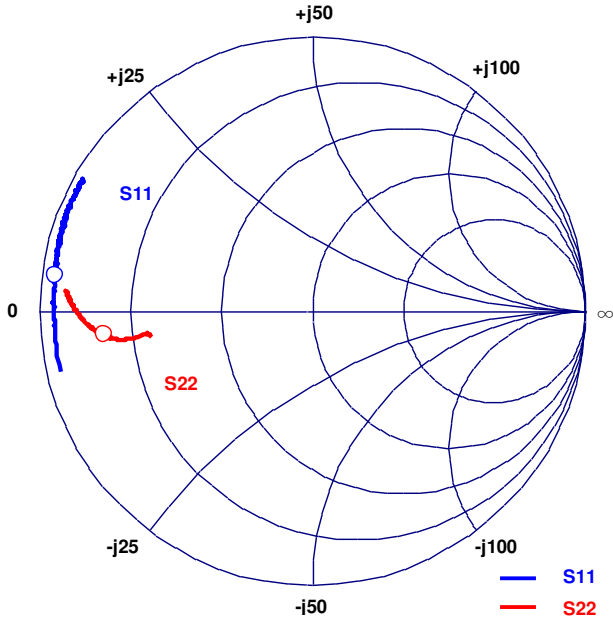
T<sub>stress</sub>: stress temperature (K)

T<sub>use</sub>: use temperature (K)

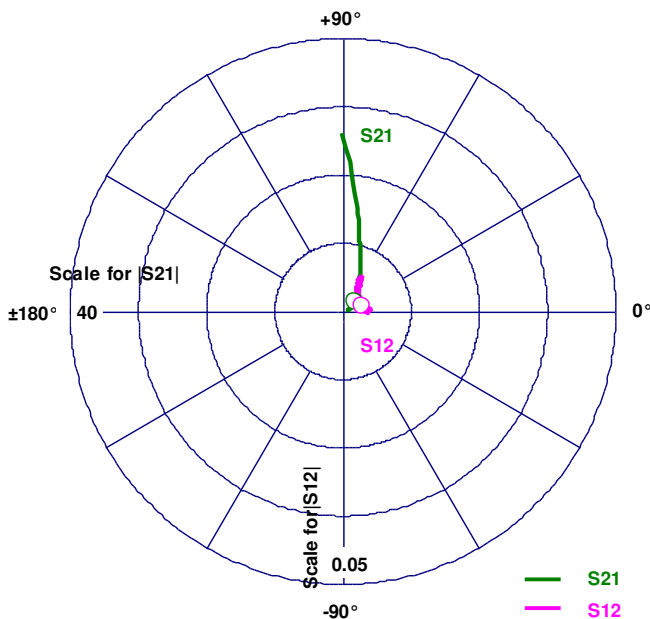
### ESD characteristic

| Test Methodology                       | Class |
|--|-------|
| Human Body Model<br>(per JESD22-A114)  | 1B    |
| Machine Model<br>(per JEIA/ESD22-A115) | A     |

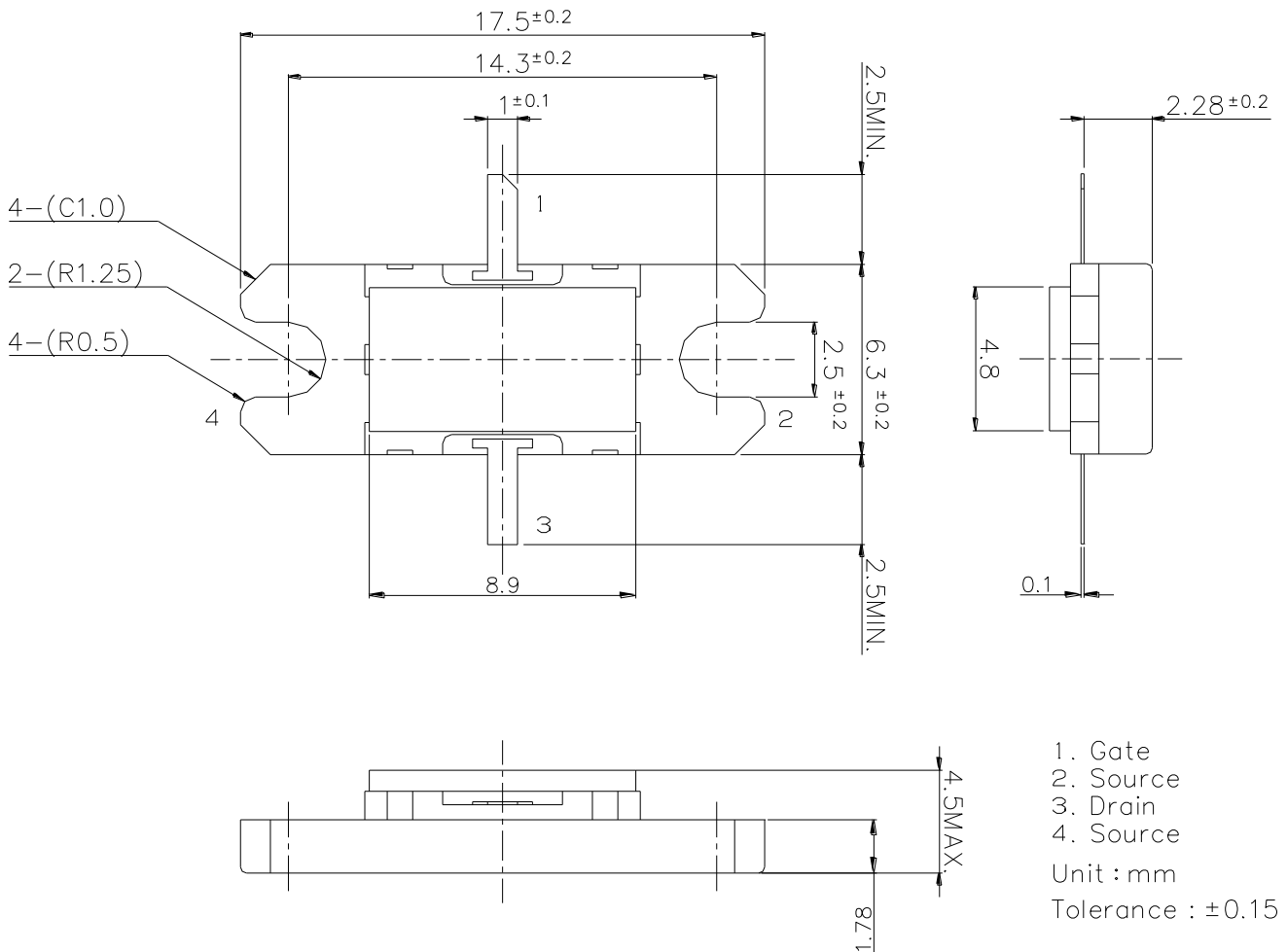
S-Parameters @V<sub>DS</sub>=50V, I<sub>DS(DC)</sub>=750mA, f=0.1 to 3.1GHz  
 Z<sub>i</sub> = Z<sub>s</sub> = 50 ohm      Marker : 0.9GHz



| Freq.<br>GHz | S11  |         | S21   |        | S12   |       | S22  |         |
|--------------|------|---------|-------|--------|-------|-------|------|---------|
|              | MAG  | ANG     | MAG   | ANG    | MAG   | ANG   | MAG  | ANG     |
| 0.10         | 0.95 | -166.25 | 26.13 | 90.06  | 0.005 | 8.04  | 0.60 | -170.68 |
| 0.20         | 0.95 | -174.87 | 12.83 | 79.54  | 0.005 | 1.70  | 0.61 | -172.09 |
| 0.30         | 0.95 | -178.43 | 8.37  | 71.98  | 0.005 | -3.78 | 0.63 | -171.79 |
| 0.25         | 0.95 | -176.75 | 10.16 | 75.53  | 0.005 | 1.09  | 0.62 | -172.04 |
| 0.40         | 0.94 | 179.26  | 6.09  | 65.00  | 0.005 | 2.97  | 0.65 | -171.27 |
| 0.50         | 0.95 | 177.74  | 4.69  | 58.95  | 0.004 | 0.83  | 0.68 | -171.15 |
| 0.60         | 0.95 | 176.19  | 3.77  | 53.60  | 0.004 | 3.77  | 0.70 | -171.19 |
| 0.70         | 0.95 | 174.77  | 3.10  | 47.97  | 0.004 | 7.41  | 0.73 | -171.74 |
| 0.80         | 0.95 | 173.36  | 2.62  | 43.45  | 0.004 | 9.08  | 0.75 | -172.32 |
| 0.90         | 0.95 | 172.24  | 2.22  | 39.08  | 0.004 | 13.17 | 0.77 | -173.35 |
| 1.00         | 0.95 | 171.07  | 1.93  | 34.59  | 0.004 | 23.42 | 0.79 | -174.11 |
| 1.10         | 0.95 | 169.96  | 1.69  | 30.38  | 0.004 | 33.31 | 0.80 | -175.03 |
| 1.20         | 0.96 | 168.74  | 1.49  | 26.67  | 0.004 | 41.79 | 0.82 | -176.12 |
| 1.30         | 0.96 | 167.53  | 1.32  | 23.31  | 0.004 | 46.56 | 0.83 | -177.10 |
| 1.40         | 0.96 | 166.52  | 1.17  | 19.84  | 0.004 | 47.02 | 0.85 | -177.98 |
| 1.50         | 0.96 | 165.79  | 1.06  | 16.98  | 0.005 | 51.22 | 0.86 | -179.16 |
| 1.60         | 0.96 | 164.63  | 0.97  | 13.59  | 0.005 | 54.38 | 0.87 | 179.85  |
| 1.70         | 0.97 | 163.86  | 0.89  | 10.86  | 0.005 | 57.67 | 0.88 | 178.76  |
| 1.80         | 0.96 | 162.62  | 0.80  | 8.19   | 0.006 | 58.39 | 0.89 | 177.85  |
| 1.90         | 0.96 | 161.81  | 0.74  | 5.81   | 0.006 | 58.24 | 0.90 | 176.99  |
| 2.00         | 0.97 | 160.73  | 0.68  | 3.10   | 0.007 | 58.48 | 0.90 | 176.04  |
| 2.10         | 0.97 | 159.74  | 0.63  | 1.39   | 0.007 | 59.15 | 0.91 | 175.26  |
| 2.20         | 0.97 | 158.91  | 0.59  | -1.42  | 0.007 | 62.51 | 0.91 | 174.43  |
| 2.30         | 0.97 | 158.23  | 0.55  | -3.01  | 0.008 | 60.55 | 0.91 | 173.51  |
| 2.40         | 0.97 | 157.05  | 0.52  | -5.63  | 0.008 | 64.19 | 0.92 | 172.92  |
| 2.50         | 0.97 | 156.47  | 0.49  | -7.02  | 0.009 | 62.21 | 0.92 | 171.85  |
| 2.60         | 0.96 | 155.13  | 0.46  | -8.75  | 0.009 | 63.44 | 0.93 | 171.42  |
| 2.70         | 0.97 | 154.08  | 0.44  | -10.43 | 0.009 | 62.18 | 0.93 | 170.60  |
| 2.80         | 0.97 | 153.15  | 0.42  | -12.80 | 0.010 | 64.83 | 0.93 | 169.95  |
| 2.90         | 0.97 | 152.50  | 0.40  | -13.65 | 0.011 | 63.31 | 0.94 | 169.28  |
| 3.00         | 0.97 | 151.20  | 0.38  | -16.58 | 0.011 | 63.94 | 0.94 | 168.54  |
| 3.10         | 0.97 | 150.54  | 0.37  | -18.81 | 0.011 | 65.28 | 0.94 | 168.10  |



### MK Package Outline Metal-Ceramic Hermetic Package





# **EGNC210MK**

***High Voltage - High Power GaN-HEMT***

**For further information please contact:**

**<http://global-sei.com/Electro-optic/about/office.html>**